



,200-327; TSMC 00-112
Serial Number 09/885,784

AMENDMENTS

In the Claims

Please amend claim 11 as follows.

11. (twice amended) A method for fabricating a semiconductor integrated circuit microelectronic fabrication comprising:

providing a first semiconductor substrate;

forming over the first semiconductor substrate at least one microelectronic device to form from the first semiconductor substrate a partially fabricated semiconductor integrated circuit microelectronic fabrication;

providing a second substrate;

forming over the second substrate, in inverted order, a dielectric isolated metallization pattern intended to mate with the partially fabricated semiconductor integrated circuit microelectronic fabrication;

laminating the partially fabricated semiconductor integrated circuit microelectronic fabrication with the second substrate to mate the partially fabricated semiconductor integrated circuit microelectronic fabrication with the dielectric isolated metallization pattern to thus form a laminated completely fabricated semiconductor integrated circuit microelectronic fabrication; and